2.5V Drive Pch+Pch MOSFET us6J2

●Structure

Silicon P-channel MOSFET

● Features

- 1) Two Pch MOSFET transistors in a single TUMT6 package.
- 2) Mounting cost and area can be cut in half.
- 3) Low on-resistance.
- 4) Low voltage drive (2.5V) makes this device ideal for portable equipment.
- 5) Drive circuits can be simple.

Applications

Switching

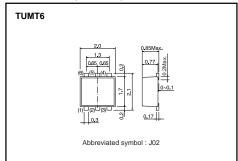
Packaging specifications

	Package	Taping
Type	Code	TR
	Basic ordering unit (pieces)	3000
US6J2		

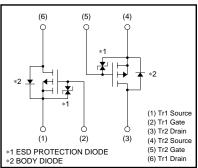
● Absolute maximum ratings (Ta=25°C)

<It is the same ratings for Tr1 and Tr2>

●Dimensions (Unit: mm)



●Inner circuit



Parameter	Symbol	Limits	Unit	
Drain-source voltage		VDSS	-20	V
Gate-source voltage		Vgss	±12	V
Drain current	Continuous	ΙD	±1	Α
	Pulsed	I _{DP} *1	±4	Α
Source current (Body diode)	Continuous	Is	-0.4	Α
	Pulsed	Isp *1	-4	Α
Total power dissipation		P _D *2	1.0	W / TOTAL
Total power dissipation	'0 -	0.7	W / ELEMENT	
Channel temperature		Tch	150	°C
Range of Storage temperature		Tstg	-55 to +150	°C

^{*1} Pw≤10μs, Duty cycle≤50% *2 Mounted on a ceramic board

Thermal resistance

Parameter	Symbol	Limits	Unit
Channel to ambient	Dth(ah a)*	125	°C/W / TOTAL
Channel to ambient	Rth(ch-a)	179	°C/W / ELEMENT

^{*} Mounted on a ceramic board

●Electrical characteristics (Ta=25°C)

<It is the same characteristics for Tr1 and Tr2 MOSFET>

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions	
Gate-source leakage	I _{GSS}	_	-	±10	μΑ	V _{GS} =±12V, V _{DS} =0V	
Drain-source breakdown voltage	V _(BR) DSS	-20	-	-	V	I _D = -1mA, V _{GS} =0V	
Zero gate voltage drain current	I _{DSS}	-	-	-1.0	μΑ	V _{DS} = -20V, V _{GS} =0V	
Gate threshold voltage	V _{GS (th)}	-0.7	_	-2.0	V	V _{DS} = -10V, I _D = -1mA	
Static drain-source on-state	R _{DS} (on)	-	280	390	mΩ	I _D = -1A, V _G S= -4.5V	
		_	310	430	mΩ	I _D = -1A, V _G S= -4V	
resistance		_	570	800	mΩ	Ip= -0.5A, Vgs= -2.5V	
Forward transfer admittance	Y _{fs} *	0.7	-	-	S	V _{DS} = -10V, I _D = -0.5A	
Input capacitance	Ciss	-	150	-	pF	V _{DS} = -10V	
Output capacitance	Coss	_	20	_	pF	V _G s=0V	
Reverse transfer capacitance	Crss	-	20	-	pF	f=1MHz	
Turn-on delay time	t _{d (on)} *	-	9	-	ns	ID= -0.5A	
Rise time	tr *	_	8	_	ns	VDD≒ −15V VGS= −4.5V RL=30Ω	
Turn-off delay time	t _{d (off)} *	_	25	_	ns		
Fall time	t _f *	-	10	-	ns	R _G =10Ω	
Total gate charge	Qg *	-	2.1	-	nC	V _{DD} ≒−15V R _L =15Ω	
Gate-source charge	Q _{gs} *	-	0.5	-	nC	V _{GS} = -4.5V R _G =10Ω	
Gate-drain charge	Q _{gd} *	_	0.5	_	nC	I _D = -1A	

^{*} Pulsed

<Body diode (Source-drain)>

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Forward voltage	Vsp	_	-	-1.2	V	Is= -0.4A. V _{GS} =0V

Electrical characteristic curves

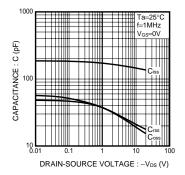


Fig.1 Typical Capacitance vs. Drain-Source Voltage

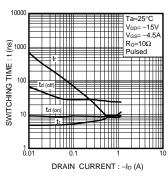


Fig.2 Switching Characteristics

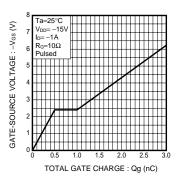


Fig.3 Dynamic Input Characteristics

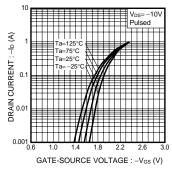


Fig.4 Typical Transfer Characteristics

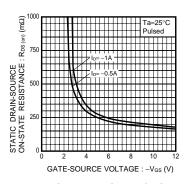


Fig.5 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

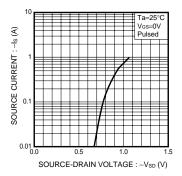


Fig.6 Source Current vs. Source-Drain Voltage

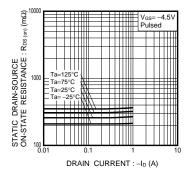


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current (II)

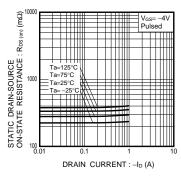


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current (III)

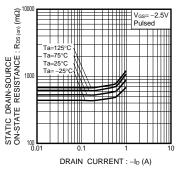


Fig.9 Static Drain-Source On-State Resistance vs. Drain Current (I)

●Measurement circuits

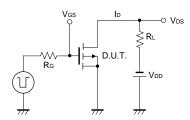


Fig.10 Switching Time Measurement Circuit

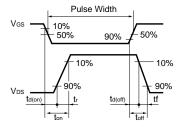


Fig.11 Switching Waveforms

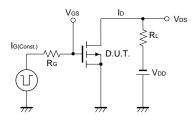


Fig.12 Gate Charge Measurement Circuit

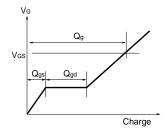


Fig.13 Gate Charge Waveform

Notes

- No technical content pages of this document may be reproduced in any form or transmitted by any
 means without prior permission of ROHM CO.,LTD.
- The contents described herein are subject to change without notice. The specifications for the
 product described in this document are for reference only. Upon actual use, therefore, please request
 that specifications to be separately delivered.
- Application circuit diagrams and circuit constants contained herein are shown as examples of standard
 use and operation. Please pay careful attention to the peripheral conditions when designing circuits
 and deciding upon circuit constants in the set.
- Any data, including, but not limited to application circuit diagrams information, described herein are intended only as illustrations of such devices and not as the specifications for such devices. ROHM CO.,LTD. disclaims any warranty that any use of such devices shall be free from infringement of any third party's intellectual property rights or other proprietary rights, and further, assumes no liability of whatsoever nature in the event of any such infringement, or arising from or connected with or related to the use of such devices.
- Upon the sale of any such devices, other than for buyer's right to use such devices itself, resell or
 otherwise dispose of the same, no express or implied right or license to practice or commercially
 exploit any intellectual property rights or other proprietary rights owned or controlled by
- ROHM CO., LTD. is granted to any such buyer.
- Products listed in this document are no antiradiation design.

The products listed in this document are designed to be used with ordinary electronic equipment or devices (such as audio visual equipment, office-automation equipment, communications devices, electrical appliances and electronic toys).

Should you intend to use these products with equipment or devices which require an extremely high level of reliability and the malfunction of with would directly endanger human life (such as medical instruments, transportation equipment, aerospace machinery, nuclear-reactor controllers, fuel controllers and other safety devices), please be sure to consult with our sales representative in advance.

About Export Control Order in Japan

Products described herein are the objects of controlled goods in Annex 1 (Item 16) of Export Trade Control Order in Japan.

In case of export from Japan, please confirm if it applies to "objective" criteria or an "informed" (by MITI clause) on the basis of "catch all controls for Non-Proliferation of Weapons of Mass Destruction.

ROHM

Appendix1-Rev1.1